

## Refine Search

### Search Results -

Terms	Documents
L14 and (probability near distribut\$4)	0

Database:

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Search:

L15

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<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>			
<u>L15</u>	L14 and (probability near distribut\$4)	0	<u>L15</u>
<u>L14</u>	L13 and ((data near mining) same model)	3	<u>L14</u>
<u>L13</u>	(L9 or L10 or L11) and L1	188	<u>L13</u>
<u>L12</u>	(L9 or L10 or L11) and L4	0	<u>L12</u>
<u>L11</u>	709/225.ccls.	1643	<u>L11</u>
<u>L10</u>	709/219.ccls.	2803	<u>L10</u>
<u>L9</u>	709/218.ccls.	1477	<u>L9</u>
<u>L8</u>	(L6 or L4) and ((data near mining) same model)	2	<u>L8</u>
<u>L7</u>	(L6 or L4) and (data near mining)	4	<u>L7</u>
<u>L6</u>	L5 and L4	3	<u>L6</u>
<u>L5</u>	707/\$.ccls.	24418	<u>L5</u>
<u>L4</u>	L3 and (probability near distribut\$4)	5	<u>L4</u>
<u>L3</u>	L2 and (perturb\$ near data)	17	<u>L3</u>

<u>L2</u>	L1 and perturb\$	347	<u>L2</u>
<u>L1</u>	estimat\$4 and distribut\$4 and (value or data) and (generat\$4 or develop\$3 or creat\$3 or build\$3) and securit\$3	10203	<u>L1</u>

END OF SEARCH HISTORY

## Refine Search

### Search Results -

Terms	Documents
(L9 or L10 or L11) and L4	0

Database:

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Search:

L12

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<u>L12</u>	(L9 or L10 or L11) and L4	0	<u>L12</u>
<u>L11</u>	709/225.ccls.	1643	<u>L11</u>
<u>L10</u>	709/219.ccls.	2803	<u>L10</u>
<u>L9</u>	709/218.ccls.	1477	<u>L9</u>
<u>L8</u>	(L6 or L4) and ((data near mining) same model)	2	<u>L8</u>
<u>L7</u>	(L6 or L4) and (data near mining)	4	<u>L7</u>
<u>L6</u>	L5 and L4	3	<u>L6</u>
<u>L5</u>	707/\$.ccls.	24418	<u>L5</u>
<u>L4</u>	L3 and (probability near distribut\$4)	5	<u>L4</u>
<u>L3</u>	L2 and (perturb\$ near data)	17	<u>L3</u>
<u>L2</u>	L1 and perturb\$	347	<u>L2</u>
<u>L1</u>	estimat\$4 and distribut\$4 and (value or data) and (generat\$4 or develop\$3 or creat\$3 or build\$3) and securit\$3	10203	<u>L1</u>

END OF SEARCH HISTORY

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## Refine Search

### Search Results -

Terms	Documents
(L6 or L4) and ((data near mining) same model)	2

Database:

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Search:

L8

Refine Search

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<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>			
<u>L8</u>	(L6 or L4) and ((data near mining) same model)	2	<u>L8</u>
<u>L7</u>	(L6 or L4) and (data near mining)	4	<u>L7</u>
<u>L6</u>	L5 and L4	3	<u>L6</u>
<u>L5</u>	707/\$.ccls.	24418	<u>L5</u>
<u>L4</u>	L3 and (probability near distribut\$4)	5	<u>L4</u>
<u>L3</u>	L2 and (perturb\$ near data)	17	<u>L3</u>
<u>L2</u>	L1 and perturb\$	347	<u>L2</u>
<u>L1</u>	estimat\$4 and distribut\$4 and (value or data) and (generat\$4 or develop\$3 or creat\$3 or build\$3) and securit\$3	10203	<u>L1</u>

END OF SEARCH HISTORY

## Refine Search

### Search Results -

Terms	Documents
L3 and (probability near distribut\$4)	5

Database:

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 US Patents Full-Text Database  
 US OCR Full-Text Database  
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Search:

L4

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<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>		
<u>L4</u> L3 and (probability near distribut\$4)	5	<u>L4</u>
<u>L3</u> L2 and (perturb\$ near data)	17	<u>L3</u>
<u>L2</u> L1 and perturb\$	347	<u>L2</u>
<u>L1</u> estimat\$4 and distribut\$4 and (value or data) and (generat\$4 or develop\$3 or creat\$3 or build\$3) and securit\$3	10203	<u>L1</u>

END OF SEARCH HISTORY

## Refine Search

### Search Results -

Terms	Documents
L5 and L4	3

Database:

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Search:

L6

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<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>		
<u>L6</u> L5 and L4	3	<u>L6</u>
<u>L5</u> 707/\$.ccls.	24418	<u>L5</u>
<u>L4</u> L3 and (probability near distribut\$4)	5	<u>L4</u>
<u>L3</u> L2 and (perturb\$ near data)	17	<u>L3</u>
<u>L2</u> L1 and perturb\$	347	<u>L2</u>
<u>L1</u> estimat\$4 and distribut\$4 and (value or data) and (generat\$4 or develop\$3 or creat\$3 or build\$3) and securit\$3	10203	<u>L1</u>

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**1 Privacy-preserving distributed clustering using generative models**

Merugu, S.; Joydeep Ghosh;

Data Mining, 2003. ICDM 2003. Third IEEE International Conference on , 19-2 Nov. 2003

Pages:211 - 218

[\[Abstract\]](#)
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